Date Mailed: May 11, 2004

Sheet 1 of 1

FORM	1440*
LOKM	1447

INFORMATION DISCLOSURE STATEMENT
IN AN APPLICATION

(Use several sheets if necessary)

 Docket Number:
 Application Number:

 50019.0259US01
 10/688,657

Applicant: Qiang Luo

Filing Date: 10/17/2003

Group Art Unit: 2612

		U.S	S. PATENT DOCUME	NTS						
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIAT				
							·			
				<u> </u>		<u> </u>				
		FORE	IGN PATENT DOCUM	MENTS	· · · · · · · · · · · · · · · · · · ·					
	DOCUMENT NO.	JMENT NO. DATE COUNT	COUNTRY	CLASS	SUBCLASS	TRANSLATION				
						YES	NO			
					<u></u>					
						<u> </u>				
	OTHER	DOCUMENTS	Including Author, Title,	Date, Pertinent F	Pages, Etc.)	-				
TJH	Orly Yadid Engineering	Orly Yadid-Pecht; Geometrical Modulation Transfer Function for Different Pixel Active Area Shapes; Optical Engineering, Vol. 39, No. 4 April 2000; pgs. 859-865								
TJH	Igor Shcher 48, No. 12,	Igor Shcherback and Orly Yadid-Pecht; CMOS APS MTF Modeling; IEEE Transactions on Electron Devices, Vol 48, No. 12, December 2001; pgs. 2710-2715								
TJH	C. Marques Crosstalk o	C. Marques, P. Magnan; Experimental Characterization and Simulation of Quantum Efficiency and Optical Crosstalk of CMOS Photodiode APS; Proceedings of SPIE, Vol. 4669, January 21-23, 2002; pgs. 107-116								
тјн	Image Sens	J. S. Lee, J. Shah, M. Ed Jernigan, and R. I. Hornsey, Empirical Characterization of Lateral Crosstalk for CMOS Image Sensors and Deblurring Operations, IEEE Workshop on Charge-Coupled Devices and Advanced Image Sensors, Schloss Elmau, Elmau, Germany, 2003								

23552
PATENT TRADEMARK OFFICE

EXAMINER /Timothy J. Henn/ DATE CONSIDERED 01/04/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.